

**April 2013** 

# FQA9P25

# P-Channel QFET® MOSFET

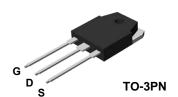
- 250 V, -10.5 A, 620 mΩ

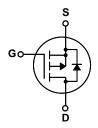
# **Description**

This P-Channel enhancement mode power MOSFET is produced using Fairchild Semiconductor®'s proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state resistance, and to provide superior switching performance and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power factor correction (PFC), and electronic lamp ballasts..

#### **Features**

- 10.5 A, 250 V,  $R_{DS(on)}$  = 620 m $\Omega$  @  $V_{GS}$  = -10 V,  $I_D$  = 5.25 A
- Low Gate Charge (Typ. 29 nC)
- Low Crss (Typ. 27 pF)
- 100% Avalanche Tested





# **Absolute Maximum Ratings** T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQA9P25	Unit
$V_{DSS}$	Drain-Source Voltage		-250	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)		-10.5	А
			-6.6	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	-42	А
$V_{GSS}$	Gate-Source Voltage		± 30	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	650	mJ
l <sub>AR</sub>	Avalanche Current	(Note 1)	-10.5	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	15	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-5.5	V/ns
PD	Power Dissipation (T <sub>C</sub> = 25°C)		150	W
	- Derate above 25°C		1.2	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

## **Thermal Characteristics**

Symbol	Parameter	FQA9P25	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.83	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Typ.	0.24	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	40	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$				V
$\Delta BV_{DSS}$ / $\Delta T_{.1}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = -250 μA, Referenced to 25°C		-0.2		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -250 V, V <sub>GS</sub> = 0 V			-1	μА
200		V <sub>DS</sub> = -200 V, T <sub>C</sub> = 125°C			-10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
On Cha	racteristics					
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250 μA			-5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = -10 V, I <sub>D</sub> = -5.25 A		0.48	0.62	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = -40 V, I <sub>D</sub> = -5.25 A (Note 4)	-	6.1		S
C <sub>oss</sub>	Output Capacitance Reverse Transfer Capacitance	f = 1.0 MHz		170 27	220 35	pF pF
C <sub>rss</sub>	' '	1 - 1.0 IVII IZ		27	35	pF
Switchi	ing Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = -125 V, I <sub>D</sub> = -9.4 A,	I	20	50	ns
t <sub>r</sub>	Turn-On Rise Time	$R_G = 25 \Omega$	ı	150	310	ns
$t_{d(off)}$	Turn-Off Delay Time		1	45	100	ns
	Turn-Off Fall Time	(Note 4, 5)	1	65	140	ns
				29	38	nC
Qg	Total Gate Charge	$V_{DS} = -200 \text{ V}, I_{D} = -9.4 \text{ A},$				
t <sub>f</sub> Q <sub>g</sub> Q <sub>gs</sub>	Total Gate Charge Gate-Source Charge	$V_{DS} = -200 \text{ V}, I_{D} = -9.4 \text{ A},$ $V_{GS} = -10 \text{ V}$		7.6		nC
Q <sub>g</sub> Q <sub>gs</sub>	•	1		_		nC nC
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Gate-Source Charge Gate-Drain Charge	V <sub>GS</sub> = -10 V (Note 4, 5)		7.6		
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-S	Gate-Source Charge	V <sub>GS</sub> = -10 V (Note 4, 5)		7.6	-10.5	
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-S	Gate-Source Charge Gate-Drain Charge  Source Diode Characteristics and	V <sub>GS</sub> = -10 V  (Note 4, 5)  nd Maximum Ratings ode Forward Current		7.6 14	  -10.5	nC
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub> Drain-S I <sub>S</sub>	Gate-Source Charge Gate-Drain Charge  Source Diode Characteristics and Maximum Continuous Drain-Source Diode	V <sub>GS</sub> = -10 V  (Note 4, 5)  nd Maximum Ratings ode Forward Current		7.6		nC A
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Gate-Source Charge Gate-Drain Charge  Source Diode Characteristics at Maximum Continuous Drain-Source Diode Maximum Pulsed Drain-Source Diode F	v <sub>GS</sub> = -10 V  (Note 4, 5)  nd Maximum Ratings ode Forward Current  Forward Current		7.6	-42	nC A A

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 9.4mH, I<sub>AS</sub> = -10.5A, V<sub>DD</sub> = -50V, R<sub>G</sub> = 25  $\Omega$ , Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub>  $\leq$  -9.4A, di/dt  $\leq$  300A/μs, V<sub>DD</sub>  $\leq$  BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width  $\leq$  300 $\mu$ s, Duty cycle  $\leq$  2% 5. Essentially independent of operating temperature

# **Typical Characteristics**

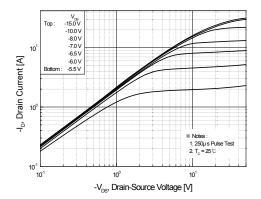


Figure 1. On-Region Characteristics

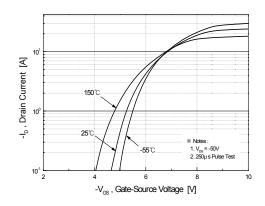


Figure 2. Transfer Characteristics

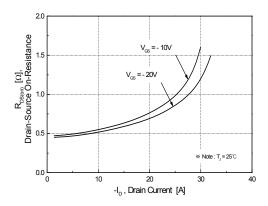


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

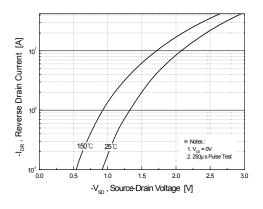


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

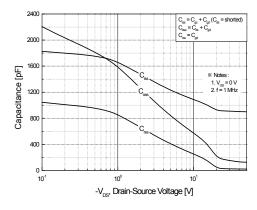


Figure 5. Capacitance Characteristics

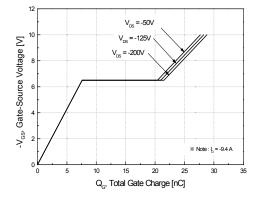
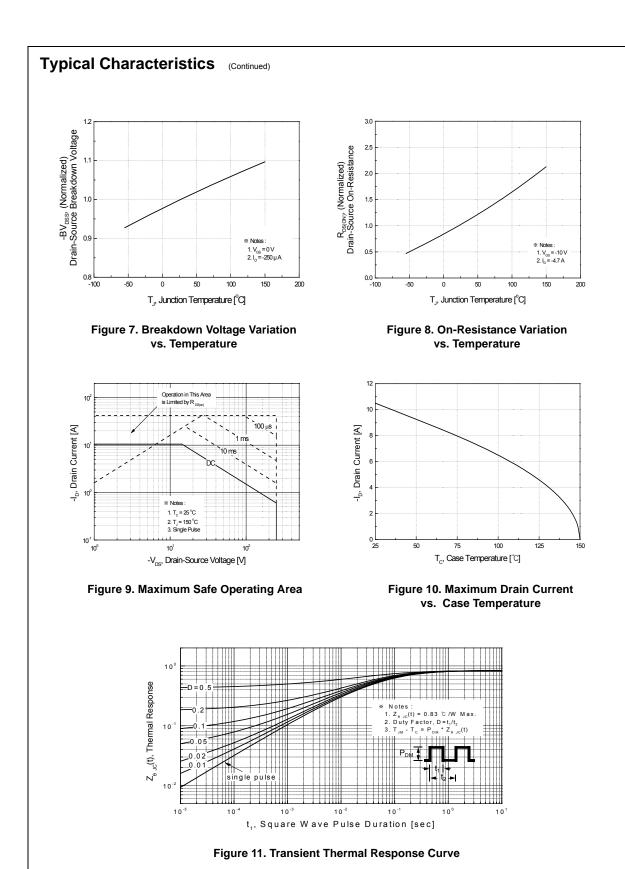
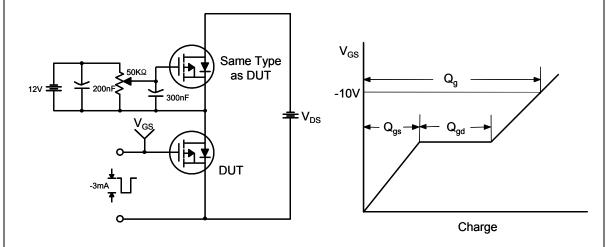


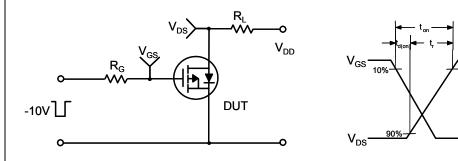
Figure 6. Gate Charge Characteristics



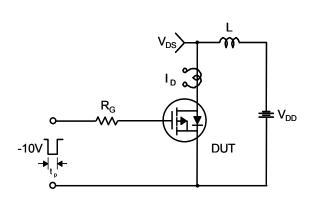


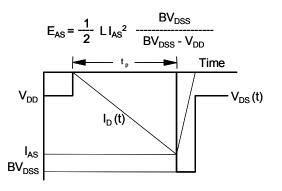


# **Resistive Switching Test Circuit & Waveforms**

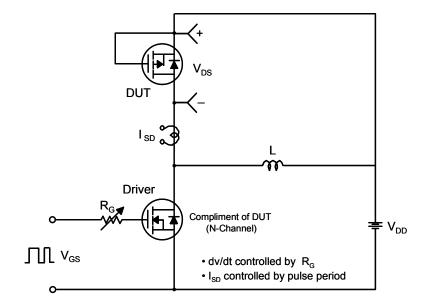


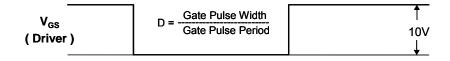
# **Unclamped Inductive Switching Test Circuit & Waveforms**

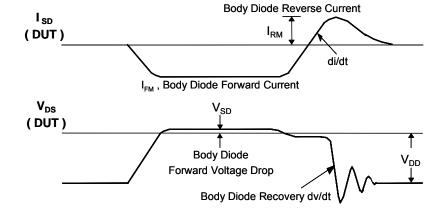




# Peak Diode Recovery dv/dt Test Circuit & Waveforms

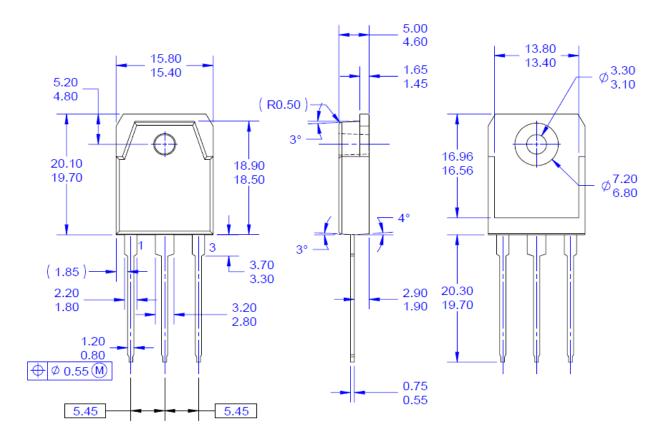






# **Mechanical Dimensions**

# TO-3PN





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- ASME14.5
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**Dimensions in Millimeters** 





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